AT27C256R

Features

- Fast Read Access Time 45 ns
- Low Power CMOS Operation 100 μA max. Standby 20 mA max. Active at 5 MHz
- JEDEC Standard Packages 28-Lead 600-mil PDIP 32-Lead PLCC 28-Lead TSOP and SOIC
- 5V ± 10% Supply
- High Reliability CMOS Technology 2,000V ESD Protection 200 mA Latchup Immunity
- Rapid[™] Programming Algorithm 100 µs/byte (typical)
- CMOS and TTL Compatible Inputs and Outputs
- Integrated Product Identification Code
- Commercial and Industrial Temperature Ranges

Description

The AT27C256R is a low-power, high performance 262,144 bit one-time programmable read only memory (OTP EPROM) organized 32K by 8 bits. It requires only one 5V power supply in normal read mode operation. Any byte can be accessed in less than 45 ns, eliminating the need for speed reducing WAIT states on high performance microprocessor systems.

Atmel's scaled CMOS technology provides low active power consumption, and fast programming. Power consumption is typically only 8 mA in Active Mode and less than 10 μ A in Standby.

(continued)

Pin Configurations

Pin Name	Function
A0 - A14	Addresses
00 - 07	Outputs
CE	Chip Enable
OE	Output Enable
NC	No Connect

PLCC Top View	
A7 VPP VCC A13	
A12 NC A14	
4 2 32 30	
A6 5 3 1 31 29 d	A8
A5 6 28 A4 7 27 A3 8 26 A2 9 25	A9
A4 \ 7 27 (A11
A3 > 8 26 <	NC
	OE
A1 \ 10 24 <	<u>A10</u>
A0 > 11 23 C	CE
NC 22 C	07
00 13 15 17 19 21 0	O6
O2 NC O4	
O1 GND O3 O5	

Note: PLCC Package Pins 1 and 17 are DON'T CONNECT.

PDIP, SOIC Top View

ſ		\sim		٦	
VPP	1		28	þ	VCC
A12 🗆	2		27	Þ	A14
A7 🗆	3		26	Þ	A13
A6 🗆	4		25	Þ	A8
A5 🗆	5		24	Þ	A9
A4 🗆	6		23	Þ	A11
АЗ 🗆	7		22	Þ	OE
A2 🗆	8		21	Þ	<u>A10</u>
A1 🗆	9		20	Þ	CE
A0 🗆	10		19	Þ	07
00 🗆	11		18	Þ	O6
01 🗆	12		17	Þ	O5
02 🗆	13		16	Þ	O4
GND 🗆	14		15	Þ	O3
				1	

			TSOP Top View Type 1					
	23	22		21	20	F	CE	A10
A9 🛛		24		19		Ē		07
A13 🛛	25 27	26		17	18	Ē	06 04	O5
vcc ^{···} h		28		15	16	Ē		О3
		2		13	14	Ĕ	GND	02
A7 4 3		4		11	12	E	01	00
A5 4 A4 A3 4		6		9	10 8	Ĕ	A0 A2	A1

AIMEL

256K (32K x 8) OTP CMOS EPROM

0014G



Description (Continued)

The AT27C256R is available in a choice of industry standard JEDEC-approved one time programmable (OTP) plastic DIP, PLCC, SOIC, and <u>TSOP</u> packages. All devices feature two-line control (CE, OE) to give designers the flexibility to prevent bus contention.

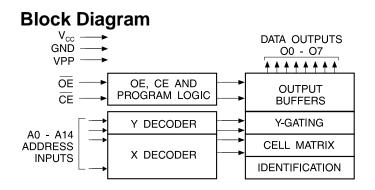
With 32K byte storage capability, the AT27C256R allows firmware to be stored reliably and to be accessed by the system without the delays of mass storage media.

Atmel's 27C256R has additional features to ensure high quality and efficient production use. The RapidTM Programming Algorithm reduces the time required to program the part and guarantees reliable programming. Programming time is typically only 100 μ s/byte. The Integrated Product Identification Code electronically identifies the device and manufacturer. This feature is used by industry standard programming equipment to select the proper programming algorithms and voltages.

System Considerations

Switching between active and standby conditions via the Chip Enable pin may produce transient voltage excursions. Unless accommodated by the system design, these transients may exceed data sheet limits, resulting in device non-conformance. At a minimum, a 0.1 μ F high frequency, low inherent inductance, ceramic capacitor should be utilized for each device. This capacitor should be connected between the V_{CC} and Ground terminals of the device, as close to the device as possible. Additionally, to stabilize the supply voltage level on printed circuit boards with large EPROM arrays, a 4.7 μ F bulk electrolytic capacitor should be utilized, again connected between the V_{CC} and Ground terminals. This capacitor should be positioned as close as possible to the point where the power supply is connected to the array.

AT27C256R



Absolute Maximum Ratings*

Temperature Under Bias55°C to +125°C
Storage Temperature65°C to +150°C
Voltage on Any Pin with Respect to Ground2.0V to +7.0V ⁽¹⁾
Voltage on A9 with Respect to Ground2.0V to +14.0V ⁽¹⁾
V _{PP} Supply Voltage with Respect to Ground2.0V to +14.0V ⁽¹⁾

*NOTICE: Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Note: 1. Minimum voltage is -0.6V dc which may undershoot to -2.0V for pulses of less than 20 ns. Maximum output pin voltage is V_{CC} + 0.75V dc which may overshoot to +7.0V for pulses of less than 20 ns.

Operating Modes

Mode \ Pin	CE	OE	Ai	Vpp	Outputs
Read	VIL	VIL	Ai	Vcc	Dout
Output Disable	VIL	Vін	X ⁽¹⁾	Vcc	High Z
Standby	VIH	X ⁽¹⁾	X ⁽¹⁾	Vcc	High Z
Rapid Program ⁽²⁾	VIL	VIH	Ai	Vpp	D _{IN}
PGM Verify ⁽²⁾	X ⁽¹⁾	VIL	Ai	Vpp	Dout
Optional PGM Verify ⁽²⁾	VIL	VIL	Ai	Vcc	Dout
PGM Inhibit ⁽²⁾	VIH	VIH	X ⁽¹⁾	Vpp	High Z
Product Identification ⁽⁴⁾	VIL	VIL	$A9 = V_{H} {}^{(3)}$ $A0 = V_{IH} \text{ or } V_{IL}$ $A1 - A14 = V_{IL}$	V _{CC}	Identification Code

Notes: 1. X can be V_{IL} or V_{IH} .

2. Refer to Programming characteristics.

3. $V_H = 12.0 \pm 0.5 V$.

4. Two identifier bytes may be selected. All Ai inputs are held low (V_{IL}), except A9 which is set to V_H and A0 which is toggled low (V_{IL}) to select the Manufacturer's Identification byte and high (V_{IH}) to select the Device Code byte.





DC and AC Operating Conditions for Read Operation

			AT27C256R									
		-45	-55	-70	-90	-12	-15					
Operating	Com.	0°C - 70°C	0°C - 70°C	0°C - 70°C	0°C - 70°C	0°C - 70°C	0°C - 70°C					
Temp. (Case)	Ind.	-40°C - 85°C	-40°C - 85°C	-40°C - 85°C	-40°C - 85°C	-40°C - 85°C	-40°C - 85°C					
Vcc Supply		$5V \pm 10\%$	$5V\pm10\%$	$5V \pm 10\%$	$5V \pm 10\%$	$5V \pm 10\%$	5V ± 10%					

DC and Operating Characteristics for Read Operation

Symbol	Parameter	Condition	Min	Мах	Units
ILI	Input Load Current	VIN = 0V to VCC		±1	μA
Ilo	Output Leakage Current	Vout = 0V to Vcc		±5	μA
I _{PP1} ⁽²⁾	V _{PP} ⁽¹⁾ Read/Standby Current	VPP = V _{CC}		10	μA
	V _{CC} ⁽¹⁾ Standby Current	I_{SB1} (CMOS), $\overline{CE} = V_{CC} \pm 0.3V$		100	μA
I _{SB}		$\overline{I_{SB2} \text{ (TTL)}}, \ \overline{CE} = 2.0 \text{ to } V_{CC} + 0.5 \text{V}$		1	mA
Icc	V _{CC} Active Current	$\frac{f = 5 \text{ MHz, I}_{OUT} = 0 \text{ mA,}$ $\overline{CE} = V_{IL}$		20	mA
VIL	Input Low Voltage		-0.6	0.8	V
VIH	Input High Voltage		2.0	V _{CC} + 0.5	V
Vol	Output Low Voltage	IoL = 2.1 mA		0.4	V
Vон	Output High Voltage	I _{OH} = -400 μA	2.4		V

Notes: 1. V_{CC} must be applied simultaneously or before V_{PP}, and removed simultaneously or after V_{PP}.

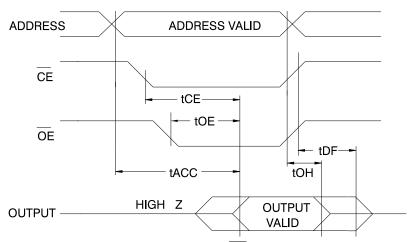
2. VPP may be connected directly to V_{CC}, except during programming. The supply current would then be the sum of I_{CC} and I_{PP} .

AC Characteristics for Read Operation

				AT27C256R											
			-4	45		55	-	70	-9	90	-'	12	-1	5	
Symbol	Parameter	Condition	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Units
t _{ACC} ⁽³⁾	Address to Output Delay	$\overline{CE} = \overline{OE} \\ = V_{IL}$		45		55		70		90		120		150	ns
t _{CE} ⁽²⁾	CE to Output Delay	$\overline{OE} = V_{IL}$		45		55		70		90		120		150	ns
toe ^(2, 3)	OE to Output Delay	$\overline{CE} = V_{IL}$		20		25		30		30		35		40	ns
t _{DF} ^(4, 5)	OE or CE High to Output Float, whichev	ver occurred first		20		20		25		25		30		35	ns
tон	Output H <u>old from</u> Address, CE or OE, whichever occurred f	rst	7		7		7		0		0		0		ns

Notes: 2, 3, 4, 5. - see AC Waveforms for Read Operation.

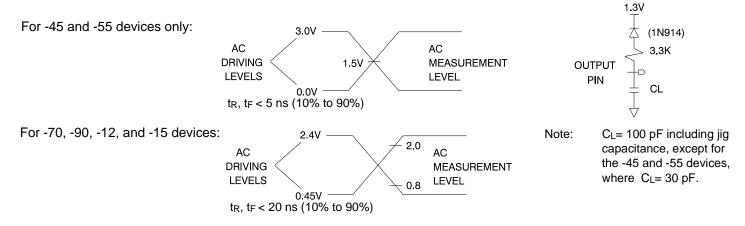
AC Waveforms for Read Operation ⁽¹⁾



- Notes: 1. Timing measurement reference level is 1.5V for -45 and -55 devices. Input AC drive levels are $V_{IL} = 0.0V$ and $V_{IH} = 3.0V$. Timing measurement reference levels for all other speed grades are $V_{OL} = 0.8V$ and $V_{OH} = 2.0V$. Input AC drive levels are $V_{IL} = 0.45V$ and $V_{IH} = 2.4V$.
 - OE may be delayed up to t_{CE} t_{OE} after the falling edge of CE without impact on t_{CE}.
- OE may be delayed up to t_{ACC} t_{OE} after the address is valid without impact on t_{ACC}.
- 4. This parameter is only sampled and is not 100% tested.
- 5. Output float is defined as the point when data is no longer driven.

Input Test Waveforms and Measurement Levels

Output Test Load



Pin Capacitance $(f = 1 MHz, T = 25 °C)^{(1)}$

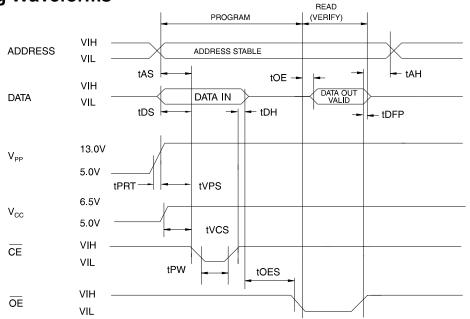
	Тур	Max	Units	Conditions	
CIN	4	6	pF	$V_{IN} = 0V$	
COUT	8	12	pF	$V_{OUT} = 0V$	

Note: 1. Typical values for nominal supply voltage. This parameter is only sampled and is not 100% tested.





Programming Waveforms⁽¹⁾



- Notes: 1. The Input Timing Reference is 0.8V for V_{IL} and 2.0V for $V_{IH}.$
 - 2. toE and tDFP are characteristics of the device but must be accommodated by the programmer.
- 3. When programming the AT27C256R a 0.1 μF capacitor is required across V_PP and ground to suppress spurious voltage transients.

DC Programming Characteristics

 T_{A} = 25 $\pm~$ 5°C, V_{CC} = 6.5 \pm 0.25V, V_{PP} = 13.0 \pm 0.25V

		Test	L		
Symbol	Parameter	Conditions	Min	Max	Units
ILI	Input Load Current	$V_{IN} = V_{IL}, V_{IH}$		±10	μA
VIL	Input Low Level		-0.6	0.8	V
VIH	Input High Level		2.0	V _{CC} + 1	V
V _{OL}	Output Low Volt.	l _{OL} = 2.1 mA		0.4	V
Vон	Output High Volt.	I _{OH} = -400 µА	2.4		V
I _{CC2}	V _{CC} Supply Current (Program and Verify)			25	mA
IPP2	V _{PP} Current	$\overline{CE} = V_{IL}$		25	mA
Vid	A9 Product Identification Voltage		11.5	12.5	V

AC Programming Characteristics

 T_{A} = 25 $\pm~$ 5°C, V_{CC} = 6.5 \pm 0.25V, V_{PP} = 13.0 \pm 0.25V

Sym- bol		est Conditions* ⁽¹⁾	Lir Min	nits Max	Units
tAS	Address Setup Tim	ne	2		μS
toes	OE Setup Time		2		μS
t _{DS}	Data Setup Time		2		μS
t _{AH}	Address Hold Time	e	0		μS
tDH	Data Hold Time		2		μS
tDFP	OE High to Out- put Float Delay ⁽²⁾		0	130	ns
tvps	V _{PP} Setup Time		2		μS
tvcs	V _{CC} Setup Time		2		μS
tpw	CE Program Pulse Width ⁽³⁾		95	105	μS
tOE	Data Valid from \overline{OE} ⁽²⁾			150	ns
t PRT	V _{PP} Pulse Rise Tir Programming	ne During	50		ns

*AC Conditions of Test:

Input Rise and Fall Times (10% to 90%)......20 ns Input Pulse Levels.....0.45V to 2.4V Input Timing Reference Level.....0.8V to 2.0V Output Timing Reference Level.....0.8V to 2.0V

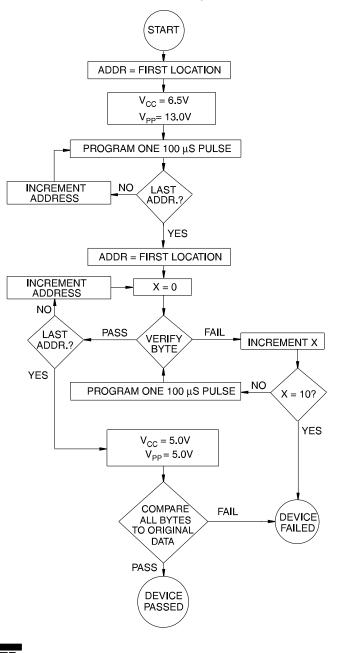
- Notes: 1. V_{CC} must be applied simultaneously or before V_{PP} and removed simultaneously or after V_{PP} .
 - This parameter is only sampled and is not 100% tested. Output Float is defined as the point where data is no longer driven — see timing diagram.
 - 3. Program Pulse width tolerance is 100 $\,\mu\text{sec}\pm5\%.$

Atmel's 27C256R Integrated Product Identification Code

		Pins					Hex			
Codes	A0	07	O6	O5	O4	O3	O2	01	00	Data
Manufacturer	0	0	0	0	1	1	1	1	0	1E
Device Type	1	1	0	0	0	1	1	0	0	8C

Rapid Programming Algorithm

A 100 μ s \overline{CE} pulse width is used to program. The address is set to the first location. V_{CC} is raised to 6.5V and V_{PP} is raised to 13.0V. Each address is first programmed with one 100 μ s \overline{CE} pulse without verification. Then a verification/reprogramming loop is executed for each address. In the event a byte fails to pass verification, up to 10 successive 100 μ s pulses are applied with a verification after each pulse. If the byte fails to verify after 10 pulses have been applied, the part is considered failed. After the byte verifies properly, the next address is selected until all have been checked. V_{PP} is then lowered to 5.0V and V_{CC} to 5.0V. All bytes are read again and compared with the original data to determine if the device passes or fails.



3-131



Ordering Information

tACC	Icc (mA)			Deskere	Operation Dense		
(ns)	(ns) Active Standby		Ordering Code	Package	Operation Range		
45	20	0.1	AT27C256R-45JC AT27C256R-45PC AT27C256R-45RC AT27C256R-45TC	32J 28P6 28R 28T	Commercial (0°C to 70°C)		
	20	0.1	AT27C256R-45JI AT27C256R-45PI AT27C256R-45RI AT27C256R-45TI	32J 28P6 28R 28T	Industrial (-40°C to 85°C)		
55	20	0.1	AT27C256R-55JC AT27C256R-55PC AT27C256R-55RC AT27C256R-55TC	32J 28P6 28R 28T	Commercial (0°C to 70°C)		
	20	0.1	AT27C256R-55JI AT27C256R-55PI AT27C256R-55RI AT27C256R-55TI	32J 28P6 28R 28T	Industrial (-40°C to 85°C)		
70	20	0.1	AT27C256R-70JC AT27C256R-70PC AT27C256R-70RC AT27C256R-70TC	32J 28P6 28R 28T	Commercial (0°C to 70°C)		
	20	0.1	AT27C256R-70JI AT27C256R-70PI AT27C256R-70RI AT27C256R-70TI	32J 28P6 28R 28T	Industrial (-40°C to 85°C)		
90	20	0.1	AT27C256R-90JC AT27C256R-90PC AT27C256R-90RC AT27C256R-90TC	32J 28P6 28R 28T	Commercial (0°C to 70°C)		
	20	0.1	AT27C256R-90JI AT27C256R-90PI AT27C256R-90RI AT27C256R-90TI	32J 28P6 28R 28T	Industrial (-40°C to 85°C)		
120	20	0.1	AT27C256R-12JC AT27C256R-12PC AT27C256R-12RC AT27C256R-12TC	32J 28P6 28R 28T	Commercial (0°C to 70°C)		
	20	0.1	AT27C256R-12JI AT27C256R-12PI AT27C256R-12RI AT27C256R-12TI	32J 28P6 28R 28T	Industrial (-40°C to 85°C)		

(continued)

tACC			Ordering Code	Paakaga	Operation Bonge		
(ns)	Active	Standby	Ordering Code	Package	Operation Range		
150	20	0.1	AT27C256R-15JC AT27C256R-15PC AT27C256R-15RC AT27C256R-15TC	32J 28P6 28R 28T	Commercial (0°C to 70°C)		
	20	0.1	AT27C256R-15JI AT27C256R-15PI AT27C256R-15RI AT27C256R-15TI	32J 28P6 28R 28T	Industrial (-40°C to 85°C)		

Ordering Information (Continued)

Package Type					
32J	32 Lead, Plastic J-Leaded Chip Carrier (PLCC)				
28P6	28 Lead, 0.600" Wide, Plastic Dual Inline Package (PDIP)				
28R	28 Lead, 0.330" Wide, Plastic Gull Wing Small Outline (SOIC)				
28T	28 Lead, Plastic Thin Small Outline Package (TSOP)				

